


<b>Search Notes</b> 	<b>Application/Control No.</b> 10045467	<b>Applicant(s)/Patent Under Reexamination</b> CHAN ET AL.
	<b>Examiner</b> Jorgensen, Leland R	<b>Art Unit</b> 2675

SEARCHED			
Class	Subclass	Date	Examiner
349	151		
349	33		
349	121, 128-130		
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345	93. 94		
345	99-103		
349	141-143		
345	87-103, 204	5/7/07	LL

SEARCH NOTES			
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East Search		5/7/07	LL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner